

SANYO Semiconductors DATA SHEET

LA79200V

Monolithic Linear IC

For extention of I²C-BUS compatible microcomputer I/O port

Overview

This LA79200V is a for extention of I²C-BUS compatible microcomputer I/O port.

Functions

- 8 bit Expanded I/O port with LED Driver
- 2 bit DAC×2

Specifications

Maximum Ratings at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Maximum supply voltage	V ₁ max		7.0	V
Allowable power dissipation	Pd max	Ta ≤ 65°C *	300	mW
Operating temperature	Topr		-10 to +65	°C
Storage temperature	Tstg		-55 to +150	°C

^{*} Mounted on a board: 114.3×76.1×1.6mm³, glass epoxy.

Operating Conditions at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Recommended supply voltage	V ₁		5.0	V
Operating supply voltage range	V ₁ op		4.5 to 5.5	V

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Electrical Characteristics at Ta = 25°C, $V_1 = 5V$

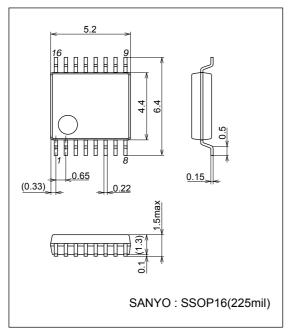
Parameter	Cumbal	Conditions		Unit		
Parameter	Symbol	Conditions	min	typ	max	Offic
[Circuit voltage, current]						
Supply current	I ₁	V ₁ =5V	7.2	8.0	8.8	mA
Supply voltage	V ₁		4.5	5.0	5.5	V
[SCL input/SDA input output]						
LOW level input voltage	ViL		0		0.8	V
HIGH level input voltage	ViH		3.5		5.0	V
DATA saturation voltage	VDAsat				0.35	V
[I/O s]						
LOW level input voltage	VIOiL		0		0.8	V
HIGH level input voltage	VIOiH		3.5		5.0	V
LOW level saturation voltage	VIOsat				0.35	V
[Slave address select]						
LOW level input voltage	VAiL		0		0.8	V
[D/A output]						
D/A LOW level output voltage	VDAL		0		0.3	V
D/A MID1 level output voltage	VDAM1		1.7	2	2.3	V
D/A MID2 level output voltage	VDAM2		2.7	3	3.3	V
D/A HIGH level output voltage	VDAH		3.8	4.1	4.4	V

Notes

- (1) Write "Hi" in the register of each port with IIC Bus when using each port as an input.
- (2) Clock rate of IIC Bus can be used at 400kHz or less.

Package Dimensions

unit : mm 3178B



Test Conditions at Ta = 25°C, $V_{CC} = V_1 = 5.0V$

Parameter	Symbol	Test point	Input signal	Test method	Bus conditions
[Circuit voltage, current]	· · · · · ·	<u> </u>			I
Supply current (pin 1)	I ₁	1	IC Add: 0111 1100	Apply a voltage of 5.0V to pin 1 and measure the incoming DC current (mA).	Initial
			Sub Add: 0000 0000		
			Data Add: 0000 0000		
[SCL input/SDA input output]		•			
LOW level input voltage	ViL	15	IC Add: 0111 1100	Measure the DC voltage at LOW level of the signal entered in pins 15 and 16.	Initial
			Sub Add: 0000 0000		
		16	Data Add: 0000 0000		
HIGH level input voltage	ViH	15	IC Add: 0111 1100	Measure the DC voltage at HIGH level of the signal entered in pins 15 and 16.	Initial
		16	Sub Add: 0000 0000		
			Data Add: 0000 0000		
DATA pin saturation voltage	VDAsat	16	IC Add: 0111 1101	Allow 3.3mA to flow through DATA pin and measure the DC voltage when ACK is returned.	Initial
[I/O s]	1				
LOW level input voltage	VIOiL	5	IC Add: 0111 1100	Measure the DC voltage of pins 5 to 8 and 10 to 13.	Initial
		to	Sub Add: 0000 0000		
		8	Data Add: 0000 0000		
		10			
		13			
HIGH level input voltage	VIOiH		IC Add:	Measure the DC voltage of pins 5 to 8	PEX0:1
		5	0111 1100 Sub Add:	and 10 to 13.	PEX1:1 PEX2:1 PEX3:1
		to 8	0000 0000 Data Add:		PEX4:1 PEX5:1 PEX6:1
		10	1111 1111		PEX7:1
		to			
		13			
				1	<u> </u>

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LOW level saturation voltage	VIOsat	5 to 8 10 to	IC Add: 0111 1100 Sub Add: 0000 0000 Data Add: 0000 0000	Measure the DC voltage when 3.3mA is allowed to flow through pin 13.	Initial
[D/A output]					
D/A output voltage H	VDAH	3	IC Add: 0111 1100 Sub Add: 0000 0001 Data Add: 0000 0000	Measure the DC voltage of pins 5 to 8 and 10 to 13.	Initial
D/A output voltage MID2	VDAM2	3	IC Add: 0111 1100 Sub Add: 0000 0001 Data Add: 0100 0100	Measure the DC voltage of pins 5 to 8 and 10 to 13.	DA.OUTPUT_1:1 DA.OUTPUT_2:1
D/A output voltage MID1	VDAM1	2 3	IC Add: 0111 1100 Sub Add: 0000 0001 Data Add: 1000 1000	Measure the DC voltage of pins 5 to 8 and 10 to 13.	DA.OUTPUT_1:2 DA.OUTPUT_2:2
D/A output voltage L	VDAL	3	IC Add: 0111 1100 Sub Add: 0000 0001 Data Add: 1100 1100	Measure the DC voltage of pins 5 to 8 and 10 to 13.	DA.OUTPUT_1:3 DA.OUTPUT_2:3

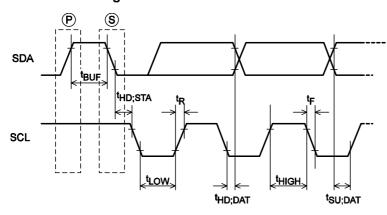
IIC input/output conditions at Ta = 25°C, $V_{CC} = 5V$

Description	Complete al	Standard		High :	Linit	
Parameter	Symbol	min	max	min	max	Unit
SCL Frequency	FSCL	0	100	0	400	kHz
BUS free time between stop - start	t _{BUF}	4.7		1.3		μS
HOLD time of start, restart condition	tHD;STA	4.0		0.6		μ\$
L time of SCL	t _{LOW}	4.7		1.3		μS
H time of SCL	^t high	4.0		0.6		μ\$
Set-up time of restart condition	^t SU;STA	4.7		0.6		μ\$
HOLD time of SDA	t _{HD;DAT}	0		0	0.9	μ\$
Set-up time of SDA	^t SU;DAT	250		100		ns
Rising time of SDA, SCL	t _R		1000	20+0.1Cb	300	ns
Falling time of SDA, SCL	t _F		300	20+0.1Cb	300	ns

Refer to figure 1

(Note) Cb : Total capacitance of all BUS (Unit : pF)

IIC BUS INPUT Timing



S: Start condition

P : Stop condition

OMT06006

IIC timing

Pin Assignment

PIN	FUNCTION	PIN	FUNCTION
1	V _{CC} 5V	16	SDA
2	DA Output 0	15	CLK
3	DA Output 1	14	ADDRESS
4	N.C.	13	I/O 0
5	I/O 7	12	I/O 1
6	I/O 6	11	I/O 2
7	I/O 5	10	I/O 3
8	I/O 4	9	GND

BUS Control Register Bit Allocation

IC Address (WRITE): 011111A0

BUS Control Register Bit Allocation Map

	2002.12.27	
	LSB	
DA6	DA7	
Bit1	Bit0	
PEX1	PEX0	

Control Register Bit Allocations								
Sub Address	MSB	DATA BITS LSB						
	DA0	DA1	DA2	DA3	DA4	DA5	DA6	DA7
	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
0000 0000	PEX7	PEX6	PEX5	PEX4	PEX3	PEX2	PEX1	PEX0
	0	0	0	0	0	0	0	0
0000 0001	DA O	utput 0	,	*		DA Output 0		*
	0	0	,	*	0	0	,	*

(Bits are transmitted in this order.)

BUS Control Register Bit Allocation Map

BUS Control Register Bit Allocation Map						IC	Address (READ)): 011111A1	
Status Register Bit Allocations									
	MSB	MSB DATA BITS LSB						LSB	
	DA0	DA1	DA2	DA3	DA4	DA5	DA6	DA7	
	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	
Status 1	PEX7	PEX6	PEX5	PEX4	PEX3	PEX2	PEX1	PEX0	
	*	*	*	*	*	*	*	*	
Status 2	(PEX7)	(PEX6)	(PEX5)	(PEX4)	(PEX3)	(PEX2)	(PEX1)	(PEX0)	
	*	*	*	*	*	*	*	*	

Bus Control Register Truth Table

Control Register Truth Table							
Register Name	0 HEX	1 HEX	2 HEX	3 HEX			
PEX 0	Low	High					
PEX 1	Low	High					
PEX 2	Low	High					
PEX 3	Low	High					
PEX 4	Low	High					
PEX 5	Low	High					
PEX 6	Low	High					
PEX 7	Low	High					
DA OUTPUT_1	High	Mid 2	Mid 1	Low			
DA OUTPUT_2	High	Mid 2	Mid 1	Low			

Bus Control Register Truth Table

Status Byte Truth Table							
Register Name	0 HEX	1 HEX	2 HEX	3 HEX			
PEX 0	Low	High					
PEX 1	Low	High					
PEX 2	Low	High					
PEX 3	Low	High					
PEX 4	Low	High					
PEX 5	Low	High					
PEX 6	Low	High					
PEX 7	Low	High					

^{(1) &}quot;A" in the IC address is set by PIN14, Address.

⁽²⁾ For the Read Status, the first 1 byte of two bytes that have been read is used. (Attempt to read only the first 1 byte may cause failure of occurrence of the STOP condition.).

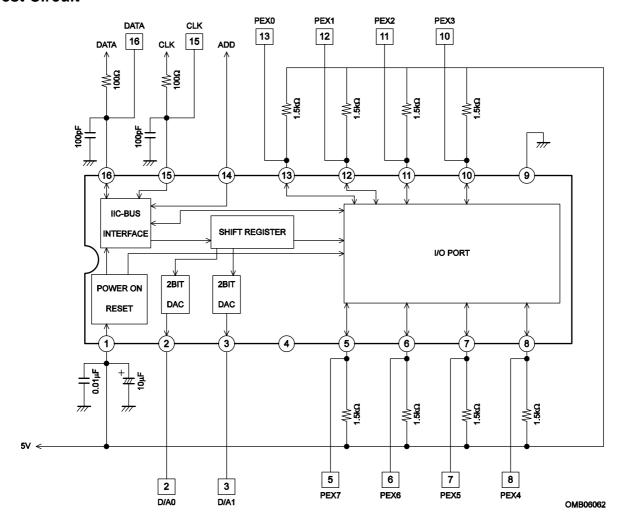
BUS Initial Conditions

Initial Test Conditions		
Register		
PEX 0	0 HEX	
PEX 1	0 HEX	
PEX 2	0 HEX	
PEX 3	0 HEX	
PEX 4	0 HEX	
PEX 5	0 HEX	
PEX 6	0 HEX	
PEX 7	0 HEX	
DA OUTPUT_1	0 HEX	
DA OUTPUT_2	0 HEX	

BUS Control Register Descriptions

Control Register Descriptions		
Register Name	Bits	General Description
PEX 0	1	I/O PORT SW
PEX 1	1	I/O PORT SW
PEX 2	1	I/O PORT SW
PEX 3	1	I/O PORT SW
PEX 4	1	I/O PORT SW
PEX 5	1	I/O PORT SW
PEX 6	1	I/O PORT SW
PEX 7	1	I/O PORT SW
DA OUTPUT_1	2	D/A OUTPUT SW
DA OUTPUT_2	2	D/A OUTPUT SW

Test Circuit



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